

<b>Notice of References Cited</b>	Application/Control No. 10/517,238		Applicant(s)/Patent Under Reexamination BAUMER ET AL.	
	Examiner Binh X. Tran		Art Unit 1792	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,482,536	11-2002	Tanaka et al.	428/626
*	B	US-5,852,162	12-1998	Smith et al.	528/272
*	C	US-5,739,204	04-1998	Piana, Hermann	524/539
*	D	US-5,623,003	04-1997	Tanaka, Shoichi	523/428
*	E	US-4,826,899	05-1989	Rees, Richard W.	524/94
*	F	US-4,734,467	03-1988	Yamada et al.	525/440.02
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.